Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | EGON SHULZ ET AL | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,144,710	11-2000	Chen et al.	375/346
	В	US-6,351,461	02-2002	Sakoda et al.	370/335
	ပ	US-6,229,792	05-2001	Anderson et al.	370/280
	D	US-5,894,472	04-1999	de Seze, Fabrice	370/337
	E	US-6,031,827	02-2000	Rikkinen et al.	370/330
	F	US-			
	O	US-			
	I	US-			
	_	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-	,		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	:				
	Q					
	R	·				
	s					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.